Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/712,440	HENNECKEN, MARK A.	
Examiner	Art Unit	
Alan S. Chen	2182	

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SEARCHED					
Class	Subclass	Date	Examiner		
360	18	4/26/2006	ASC		
1	39				
	55				
	69				
710	58				
	59				
	60	Jygay			
	61	$\downarrow$			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(EAST) USPGPUB; EPO; JPO; IBM_TDB; DERWENT PLUS; Inventor Search	4/26/2006	ASC		
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